

FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

## LIST OF REFERENCES CITED BY APPLICANT

(Use several sheets if necessary)

ATTORNEY DOCKET NO.

725.1151

APPLICATION NO.

10/45964  
25 U.S. 111  
10/45964

FIRST NAMED INVENTOR

Hiroki TAKAOKA, et al.

FILING DATE

January 15, 2002

GROUP ART UN

Unassigned

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB-CLASS	TRANSLATION YES	NO
F.S.	AG	5-274326	10/22/93	Japan			abstract	
F.S.	AH	7-199820	08/04/95	Japan			abstract	
	AI							
	AJ							
	AK							
	AL							

## OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AM	
	AN	
	AO	

EXAMINER

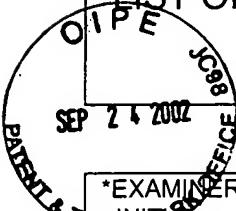
FELIX SUAREZ

DATE CONSIDERED

10/24/03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTORNEY DOCKET NO. 725.1151	APPLICATION NO. 10/045664
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		FILING DATE January 15, 2002	GROUP ART UNIT Unassigned



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F.S.	AG	WO 98/50834	11/12/98	PCT			X
F.S.	AH	1 139 264 A2	10/04/01	Europe			X
F.S.	AI	0467 584 A2	01/22/92	Europe			X
	AJ						
	AK						
	AL						

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

F.S.	AM	Tsuchiya HIDEO, PATENT ABSTRACTS OF JAPAN, PRODUCTION LINE MONITOR SYSTEM, vol. 1999, no. 11, 30 September 1999 (Publication No.: 11 161322, 6/18/99)
	AN	

EXAMINER	DATE CONSIDERED
FELIX SUAREZ	10/24/03

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